U.S. Department of Commerce, Patent and Trademark Office						Attorney Docket No.: 004-7047						
			Application No.: 10/050,358									
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U.S. Patent Documents  Date Submitted: April 10, 2003  U.S. Patent Documents												
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U.S. Patent Documents												
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no	J. Anderson et al., "Transparent, Low-Overhead Profiling on Modern Processors," Proceedings of the Workshop on Profile and Feedback-Directed Compilation in conjunction with International Conf. on Parallel Architectures and Compilation Techniques (PACT98), Paris, France, Oct. 13, 1998, 5 pp.											
M	AS	"Compaq (Digital) Continuous Profiling Infrastructure (DCPI)" 1999, [online] [Retrieved from the Internet Dec. 20, 2002] URL <a href="http://www.tru64unix.compaq.com/dcpi">http://www.research.compaq.com/SRC/dcpi</a> , 11 pp.										
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